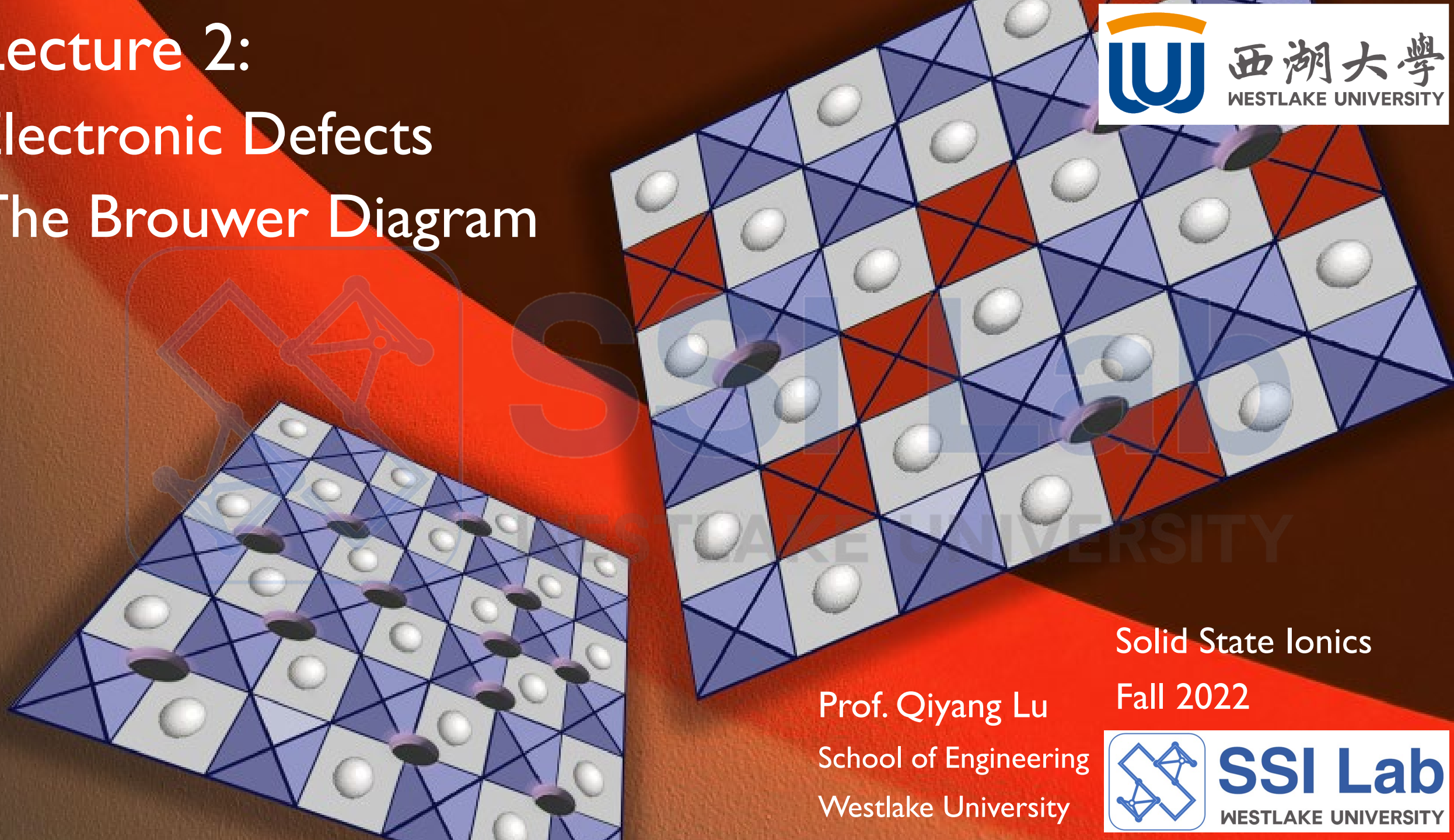


Lecture 2:

Electronic Defects

The Brouwer Diagram



Solid State Ionics

Fall 2022

Prof. Qiyang Lu

School of Engineering

Westlake University



SSI Lab
WESTLAKE UNIVERSITY

Electronic defects:

- What is the difference between electronic and ionic defects?
- A brief review on basic semiconductor physics: how to write the charge neutrality equation by using Kröger-Vink notations?

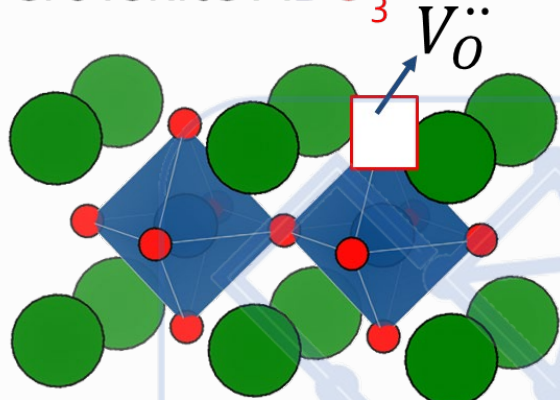
Brouwer diagrams:

- What question are we trying to solve by using the Brouwer diagram?
- What is the key assumption of Brouwer diagram (so-called Brouwer condition)?
- How does a typical Brouwer diagram for metal oxides look like? How can it be used to predict/understand the conductivity of materials?

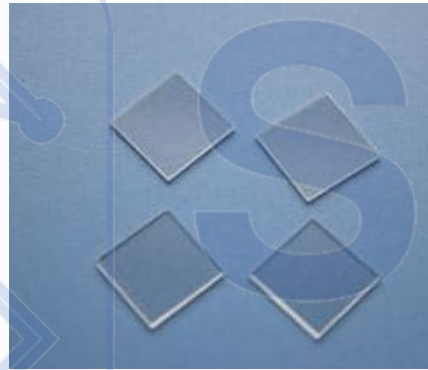
Goal of this lecture: you should be able to answer the questions above by the end of this lecture :)

Ionic vs. Electronic defects

Perovskite ABO_3



$SrTiO_{3-\delta}$ (STO)



Perovskite ABO_3 structure; Cubic (ideal tolerance factor);
("Si for perovskite oxides")

At RT (300 K): $\mu_V = 1.43 \times 10^{-13} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ (*almost negligible*);
 $\mu_n = 1.60 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$; $\mu_p = 1.27 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$

At 500°C (773 K): $\mu_V = 3.19 \times 10^{-5} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ (*still very low, but can sustain ion motion*);
 $\mu_n = 0.20 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$; $\mu_p = 0.14 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$

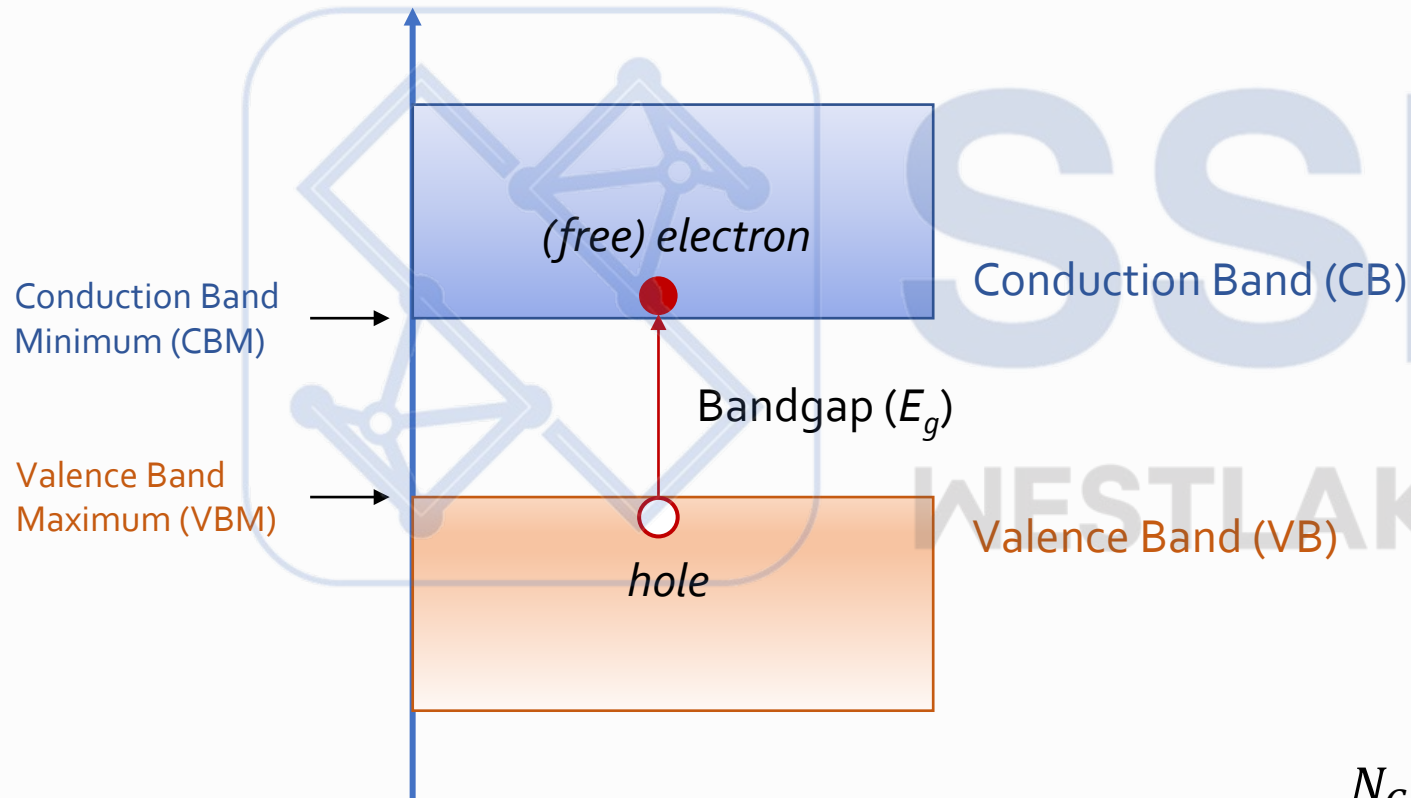
Compare **mobilities** of ionic and electronic defects

Ionic (oxygen vacancy)	$\mu_V = 1.0 \times 10^4 (T^{-1}/K^{-1})$ $\times \exp\left(-\frac{0.86 \text{ eV}}{k_B T}\right) \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$
Electronic (electrons & holes)	$\mu_n = 4.5 \times 10^5 (T/K)^{-2.2} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ $\mu_p = 8.9 \times 10^5 (T/K)^{-2.36} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$

Guo, Fleig & Maier, *SSI*, 2002

Review of semiconductor physics: intrinsic semiconductors

Electron Energy



"Band-to-band" excitation:

$$\text{null} \rightleftharpoons e' + h'$$

(free) electron hole

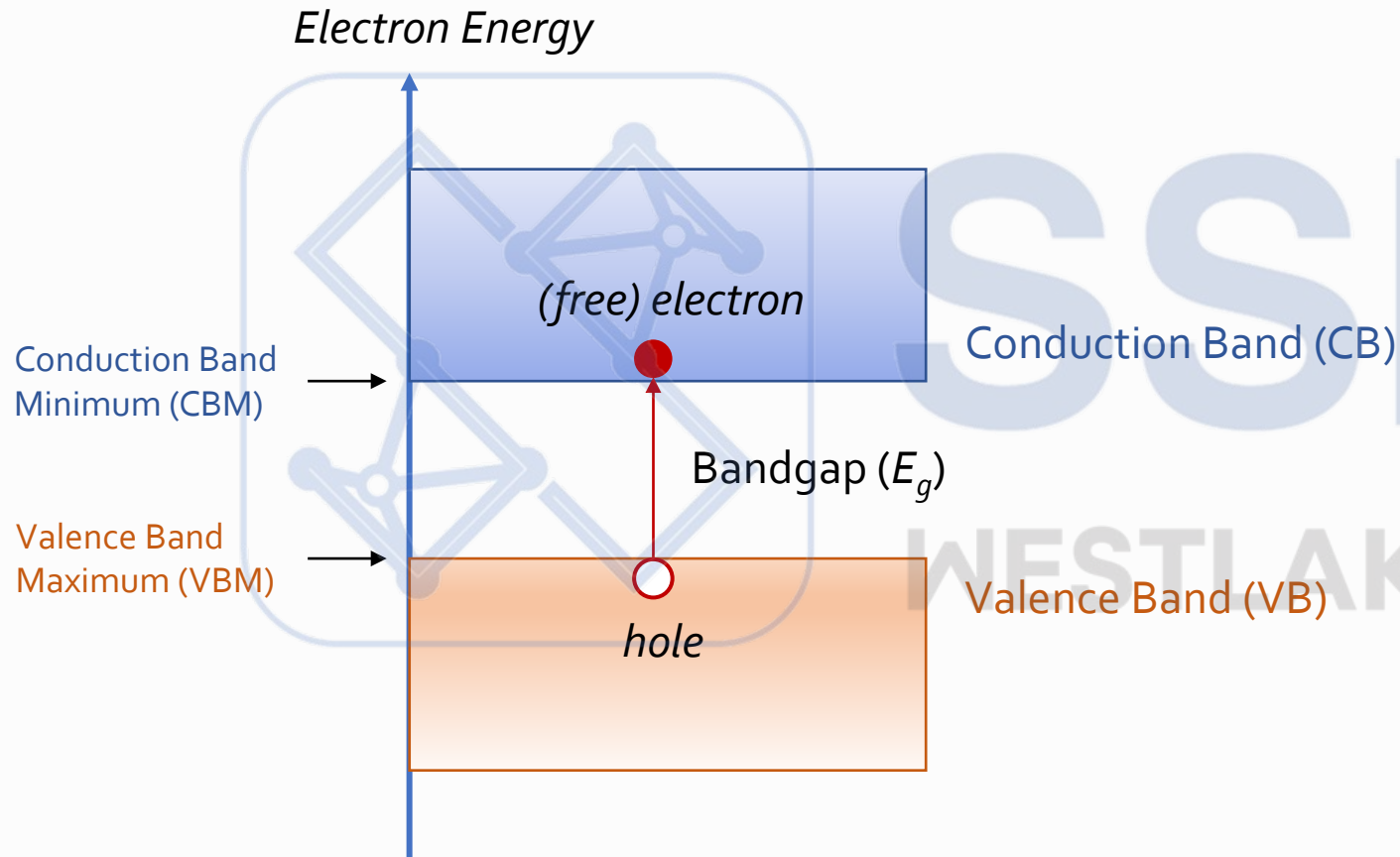
$$K_{el} = [e'] [h'] = n p$$

$$K_{el} = N_C N_V \exp\left(-\frac{E_g}{k_B T}\right)$$

N_C : effective density of state (DOS) at CBM

N_V : effective density of state (DOS) at VBM

Review of semiconductor physics: intrinsic semiconductors, cont'd



"Band-to-band" excitation:

$$\text{null} \rightleftharpoons e' + h'$$

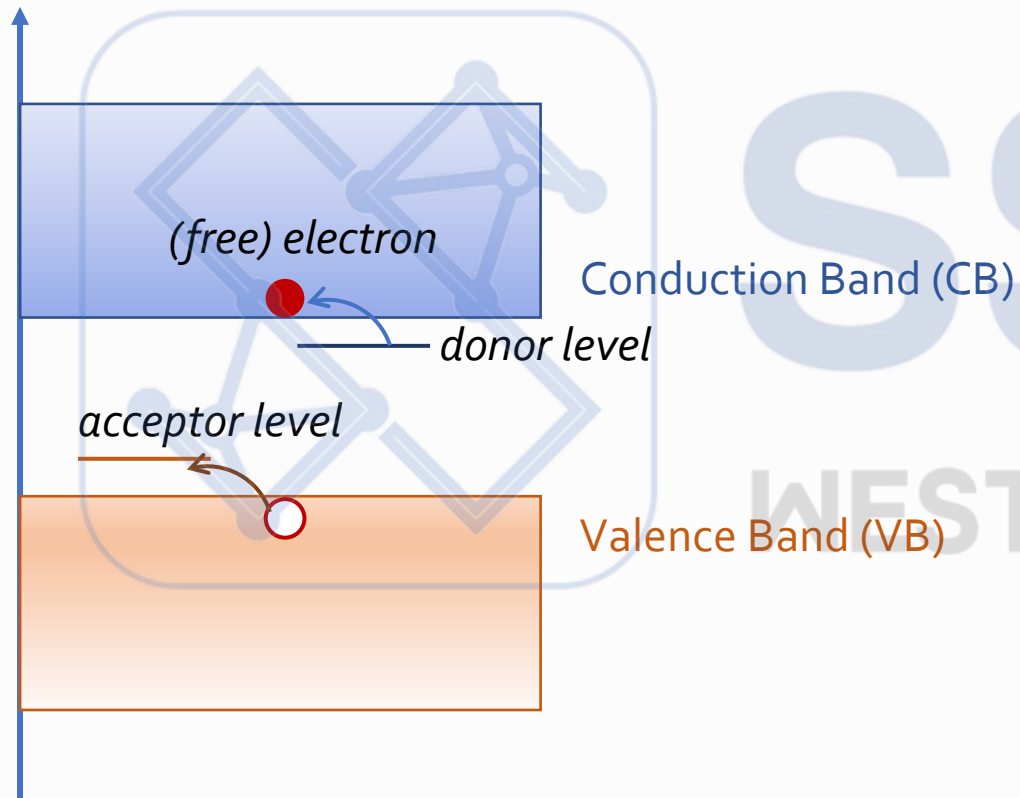
(free) electron hole

$$K_{el} = [e'] [h'] = n p$$

Intrinsic semiconductors:

$$[e'] = [h'] = \sqrt{K_{el}} \propto \exp\left(-\frac{E_g}{2k_B T}\right)$$

Electron Energy



Doping—charge neutrality condition:

$$[A'] + [e'] = [D'] + [h']$$

D' : donor, e.g., P_{Si}

A' : acceptor, e.g., B_{Si}

Intrinsic semiconductors:

$$[e'] \approx [h'] \gg [A'] \gg [D']$$

p-type semiconductors:

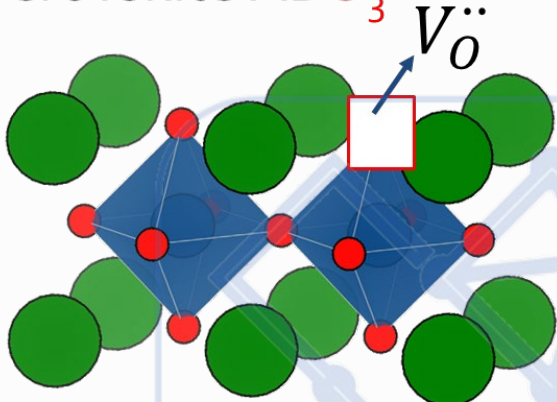
$$[A'] \approx [h'] \gg [e'] \quad ([D'] \approx 0)$$

n-type semiconductors:

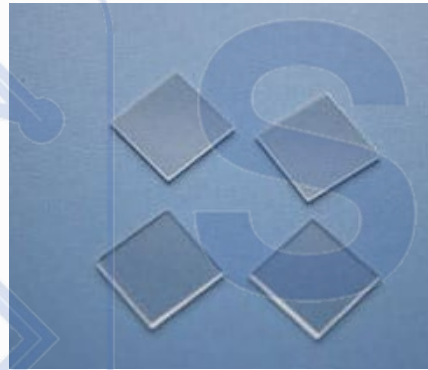
$$[D'] \approx [e'] \gg [h'] \quad ([A'] \approx 0)$$

Charge neutrality considering both ionic and electronic defects

Perovskite ABO_3



$SrTiO_{3-\delta}$ (STO)



Note: even un-doped “pure” $SrTiO_3$ single crystal contains *acceptor dopants* such as Mn, Al, Fe, Mg etc. (usually on the level of ~100 ppm, e.g. Al'_{Ti} , Mg''_{Ti})

Electronic defects: $[e']$, $[h\cdot]$

(Intrinsic) ionic defects: $[V_O^{\bullet\bullet}]$, $[O_i'']$ (uncommon), $[Ti_i^{\bullet\bullet\bullet}]$ (uncommon), $[V_{Sr}'']$, $[Sr_{Ti}'']$ (anti-site defects)

(Extrinsic) ionic defects: $[Al'_{Ti}]$, $[Mg''_{Ti}]$

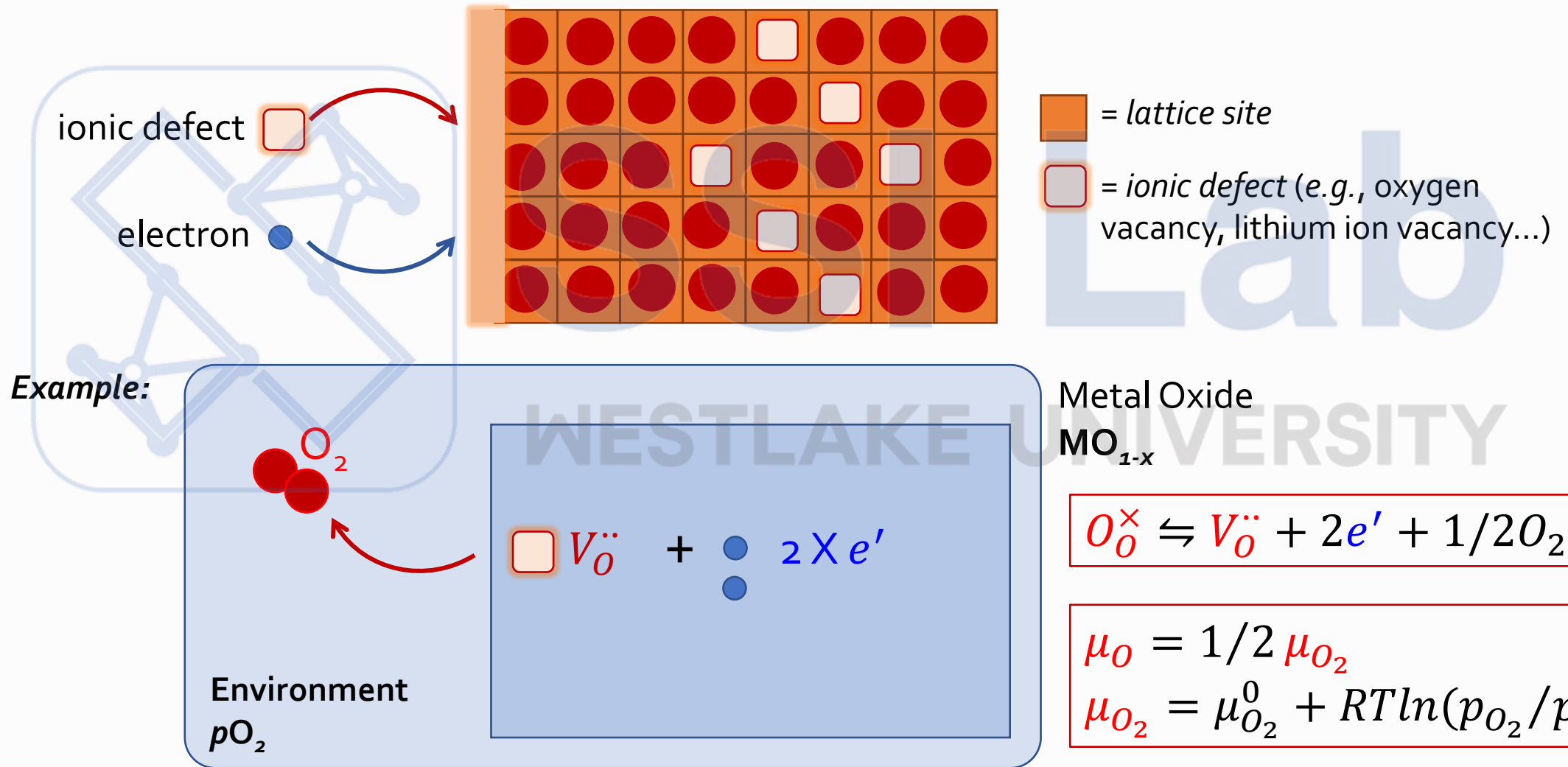
Charge neutrality considering both ionic and electronic defects:

$$[e'] + 2[V_{Sr}''] + 2[Sr_{Ti}''] + 2[O_i''] = [h\cdot] + 2[V_O^{\bullet\bullet}] + 4[Ti_i^{\bullet\bullet\bullet}]$$

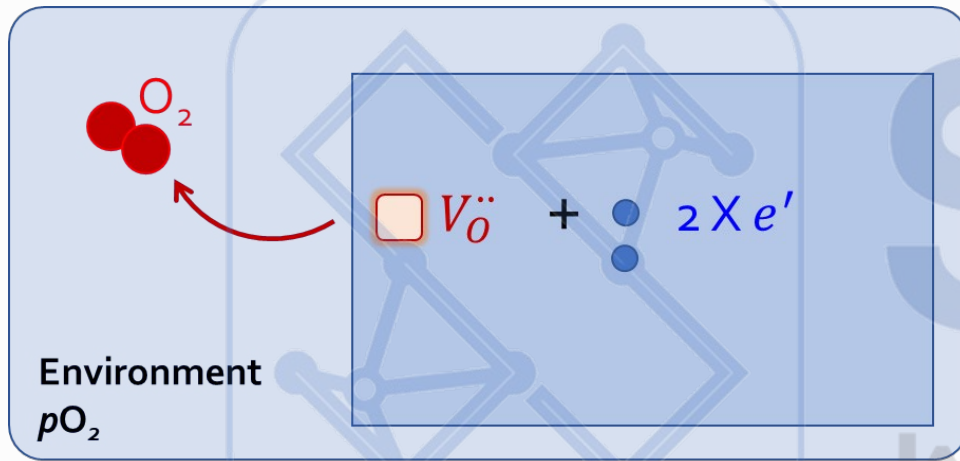
- Usually, it is very difficult to solve the equation w/ these many unknowns.
- The common practice is to ignore some defects with very low concentrations by dividing the chemical potential range into different regimes.

How to tune defect concentration?

Surfaces/Interfaces



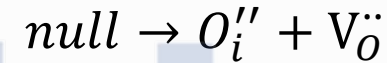
Example: Metal Oxide MO_{1-x}



Assumption: metal cations (**M**) are immobile (usually true, since the migration of cations is much more difficult compared with anions)

Defect reactions and mass action laws:

Frenkel pair



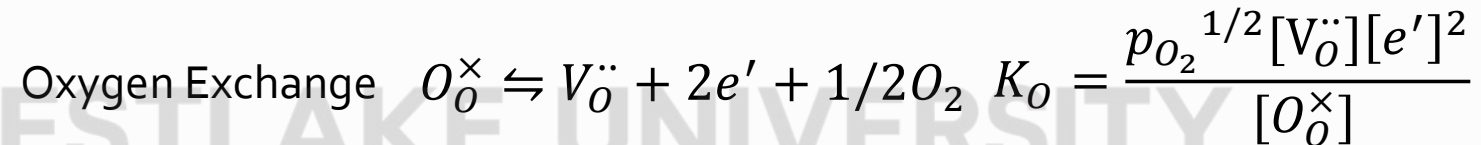
$$K_F = [O_i''] [V_{\text{O}}]$$

"Band-to-band"



$$K_{el} = [e'] [h']$$

Oxygen Exchange



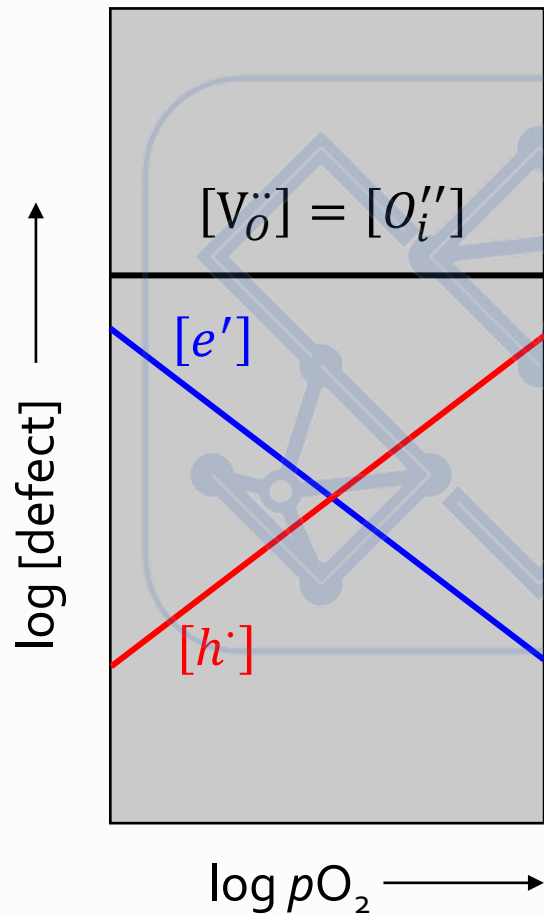
Electroneutrality also applies

$$[e'] + 2[O_i''] = [h'] + 2[V_{\text{O}}]$$

In principle, one can solve for four unknowns using these four equations, but it is much easier to **ignore the minority defects** with low enough concentration.

Brouwer condition: *only two majority defects with opposite charges matter.*

The Brouwer diagram: the $\log[\] \sim \log pO_2$ plot



Regime I: "Intrinsic" regime

The majority charge carriers are ionic defects

$$[V_{\ddot{O}}] \gg [h^{\cdot}], [O_i''] \gg [e']$$

Electroneutrality

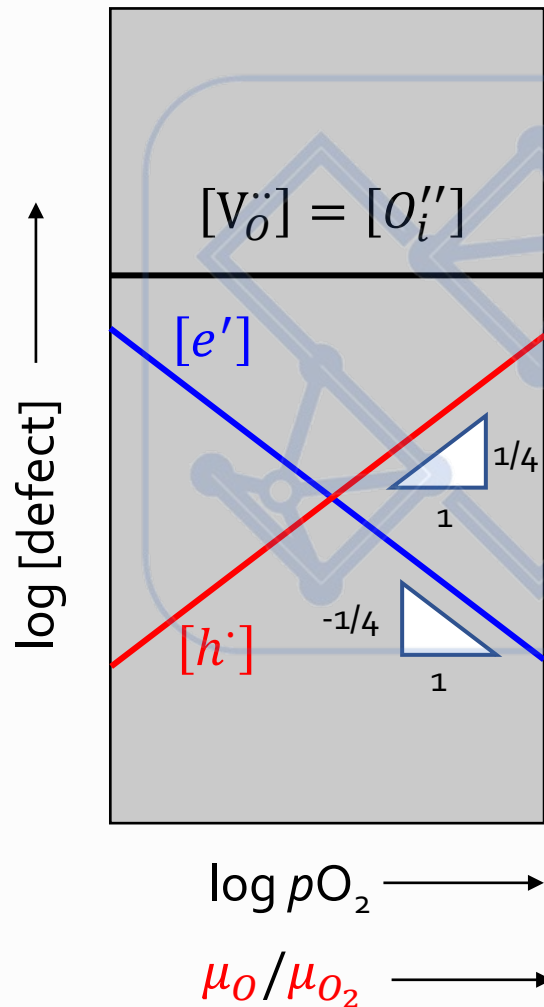
$$[e'] + 2[O_i''] = [h^{\cdot}] + 2[V_{\ddot{O}}]$$

$$\text{null} \rightarrow O_i'' + V_{\ddot{O}}, K_F = [O_i''] [V_{\ddot{O}}] \longrightarrow [O_i''] = [V_{\ddot{O}}] = \sqrt{K_F}$$

$$O_O^{\times} \rightleftharpoons V_{\ddot{O}} + 2e' + 1/2 O_2 \quad K_O = \frac{p_{O_2}^{1/2} [V_{\ddot{O}}] [e']^2}{[O_O^{\times}]}$$

$$[e'] = \sqrt{\frac{K_O}{p_{O_2}^{1/2} [V_{\ddot{O}}]}} = p_{O_2}^{-1/4} K_O^{1/2} K_F^{-1/4} \propto p_{O_2}^{-1/4}$$

Regime I: “Intrinsic” regime



Regime I: “Intrinsic” regime

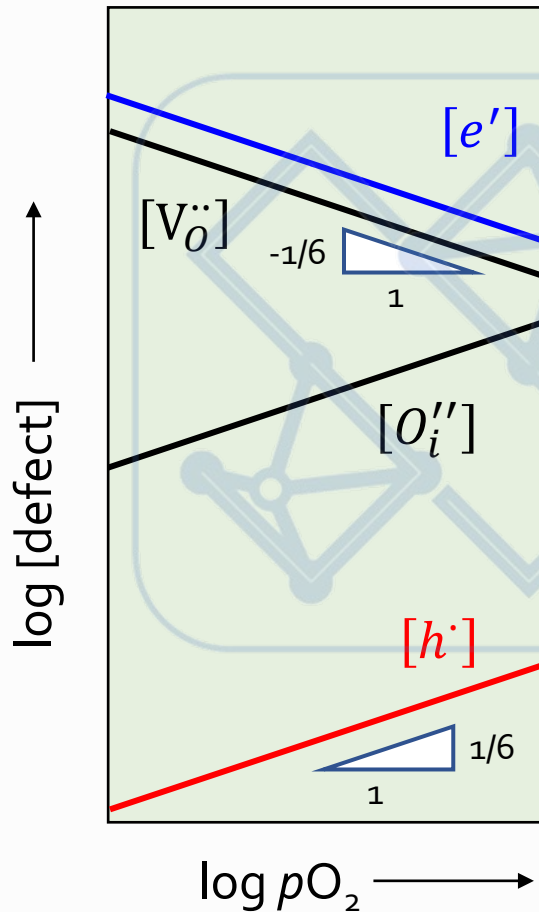
The majority charge carriers are ionic defects

$$[e'] = \sqrt{\frac{K_{\text{O}}}{p_{\text{O}_2}^{1/2} [\text{V}_{\text{O}}^{\bullet\bullet}]}} = p_{\text{O}_2}^{-1/4} K_{\text{O}}^{1/2} K_{\text{F}}^{-1/4} \propto p_{\text{O}_2}^{-1/4}$$

$$\text{null} \rightarrow e' + h^{\bullet}, K_{\text{el}} = [e'][h^{\bullet}] \longrightarrow [h^{\bullet}] \propto p_{\text{O}_2}^{1/4}$$

Notes:

- A “small” change of oxygen chemical potential can lead to **a large change in the concentration of electronic defects**;
- **n-type to p-type** transition can be triggered by changing $p\text{O}_2$



Regime II: "oxygen-poor" regime

The majority charge carriers are $[V_{\ddot{O}}]$ & $[e']$

$$[V_{\ddot{O}}] \gg [h\cdot], [e'] \gg [O_i'']$$

Electroneutrality

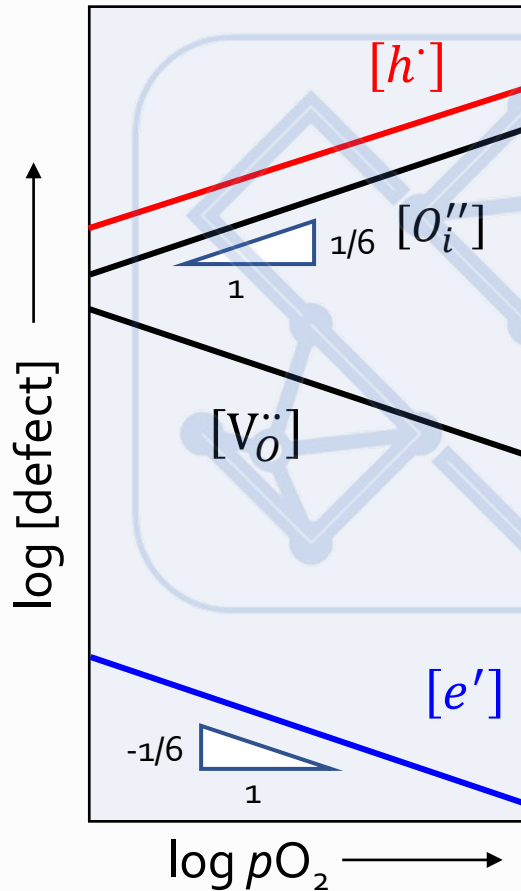
$$[e'] + 2[O_i''] = [h\cdot] + 2[V_{\ddot{O}}]$$

$$K_O = \frac{p_{O_2}^{1/2} [V_{\ddot{O}}] [e']^2}{[O_O^x]} \Rightarrow [V_{\ddot{O}}] \propto p_{O_2}^{-1/6}, [e'] \propto p_{O_2}^{-1/6}$$

$$K_{el} = [e'] [h\cdot] \Rightarrow [h\cdot] \propto p_{O_2}^{1/6}$$

$$K_F = [O_i''] [V_{\ddot{O}}] \Rightarrow [O_i''] \propto p_{O_2}^{1/6}$$

Regime III: Oxygen-rich



Regime III: "oxygen-rich" regime

The majority charge carriers are $[O_i'']$ & $[h\cdot]$

$$[h\cdot] \gg [V_{\ddot{O}}], [O_i''] \gg [e']$$

Electroneutrality

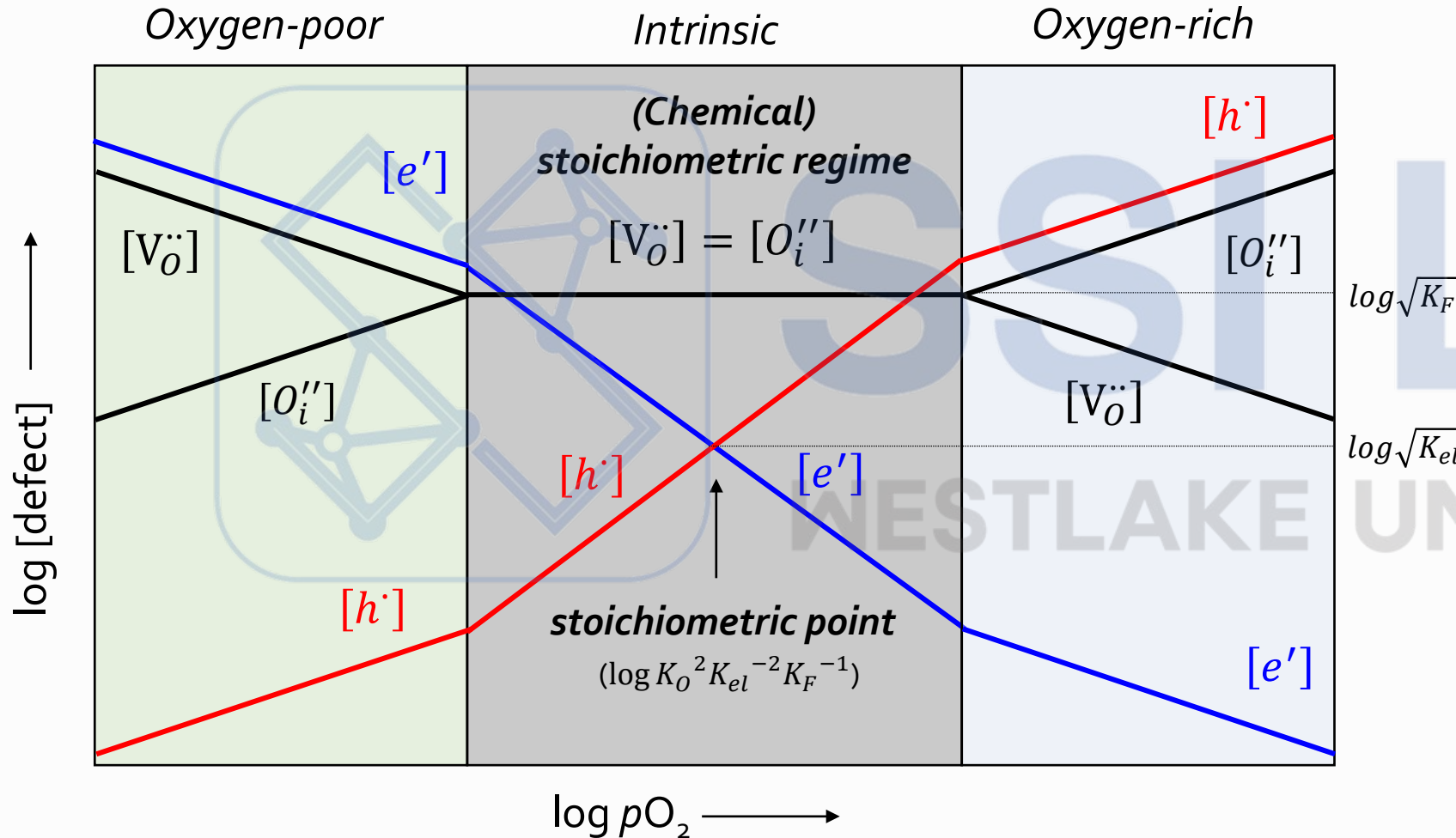
$$[e'] + 2[O_i''] = [h\cdot] + 2[V_{\ddot{O}}]$$

It is more convenient to rewrite the oxygen incorporation reaction in this case:

$$\boxed{\frac{1}{2} O_2 \rightleftharpoons O_i'' + 2h\cdot} \quad K_O = \frac{[O_i''] [h\cdot]^2}{p_{O_2}^{1/2}} \Rightarrow [O_i''] \propto p_{O_2}^{1/6} \quad [h\cdot] \propto p_{O_2}^{1/6}$$

$$K_{el} = [e'] [h\cdot] \Rightarrow [e'] \propto p_{O_2}^{-1/6} \quad K_F = [O_i''] [V_{\ddot{O}}] \Rightarrow [V_{\ddot{O}}] \propto p_{O_2}^{-1/6}$$

Combine the three regimes together: a prototypical Brouwer diagram of metal oxides



Note:

- We only considered intrinsic Frenkel pairs → can be extended to **extrinsic ionic defects** or **Schottky pairs** ($V_{\text{O}} + V_{\text{M}}''$);
- The x-axis can be expressed by either $\log p\text{O}_2$ or chemical potential of oxygen gas/neutral oxygen;
- The existence of a **stoichiometric point**.

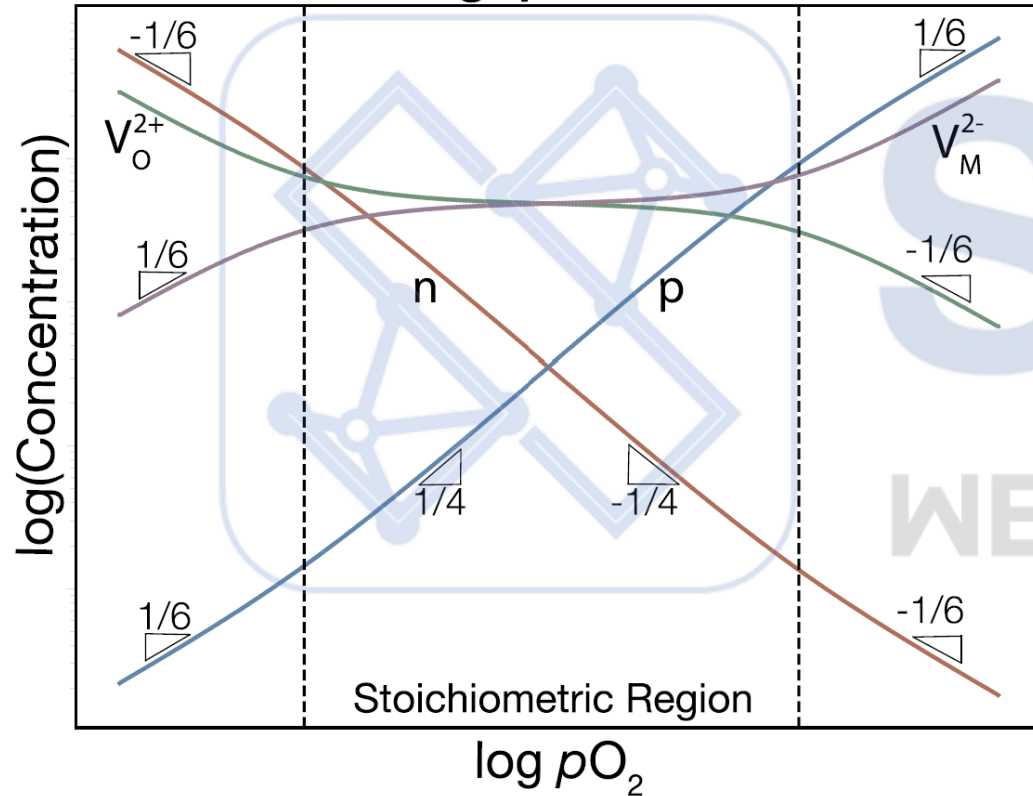
Metal Oxide $\text{MO}_{1-\delta}$

$$\delta = [O_i''] - [V_{\text{O}}]$$

More “realistic” Brouwer diagram w/ Schottky pairs or extrinsic ionic defects

$$K_{el} \ll K_S (E_g > \Delta G_{Sch}^0)$$

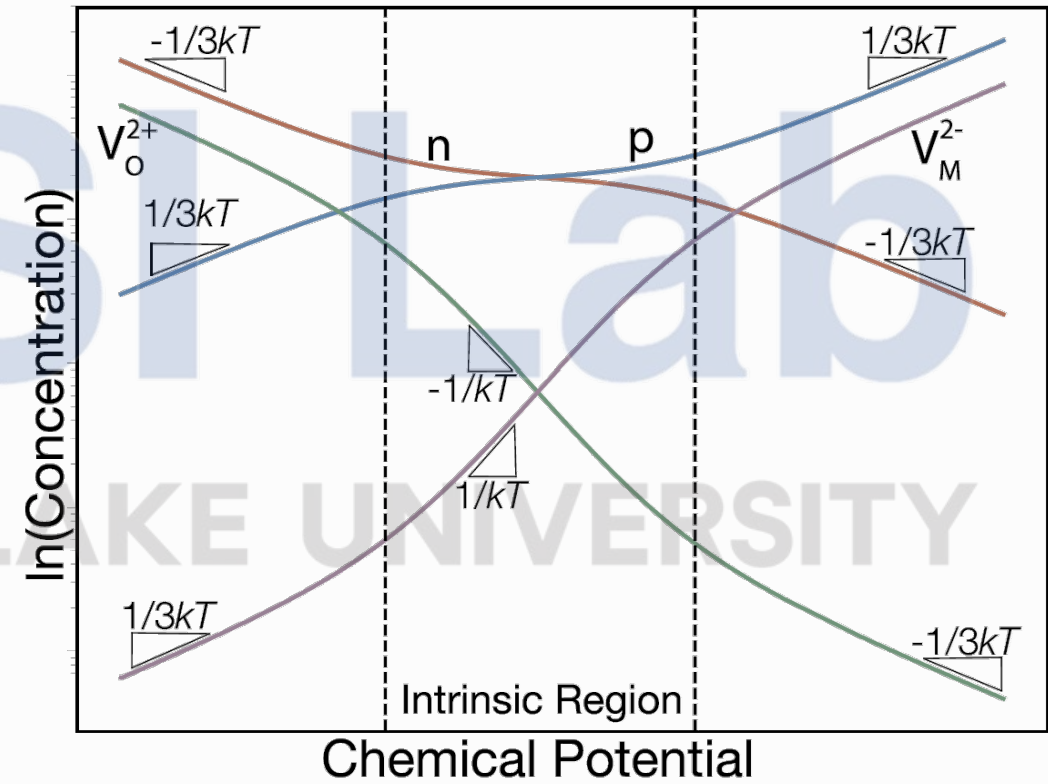
Wide Band-gap Ion Conductor



Anand, Haile, Snyder et al., *Acc. Mater. Res.*, 2022

$$K_{el} \gg K_S (E_g < \Delta G_{Sch}^0)$$

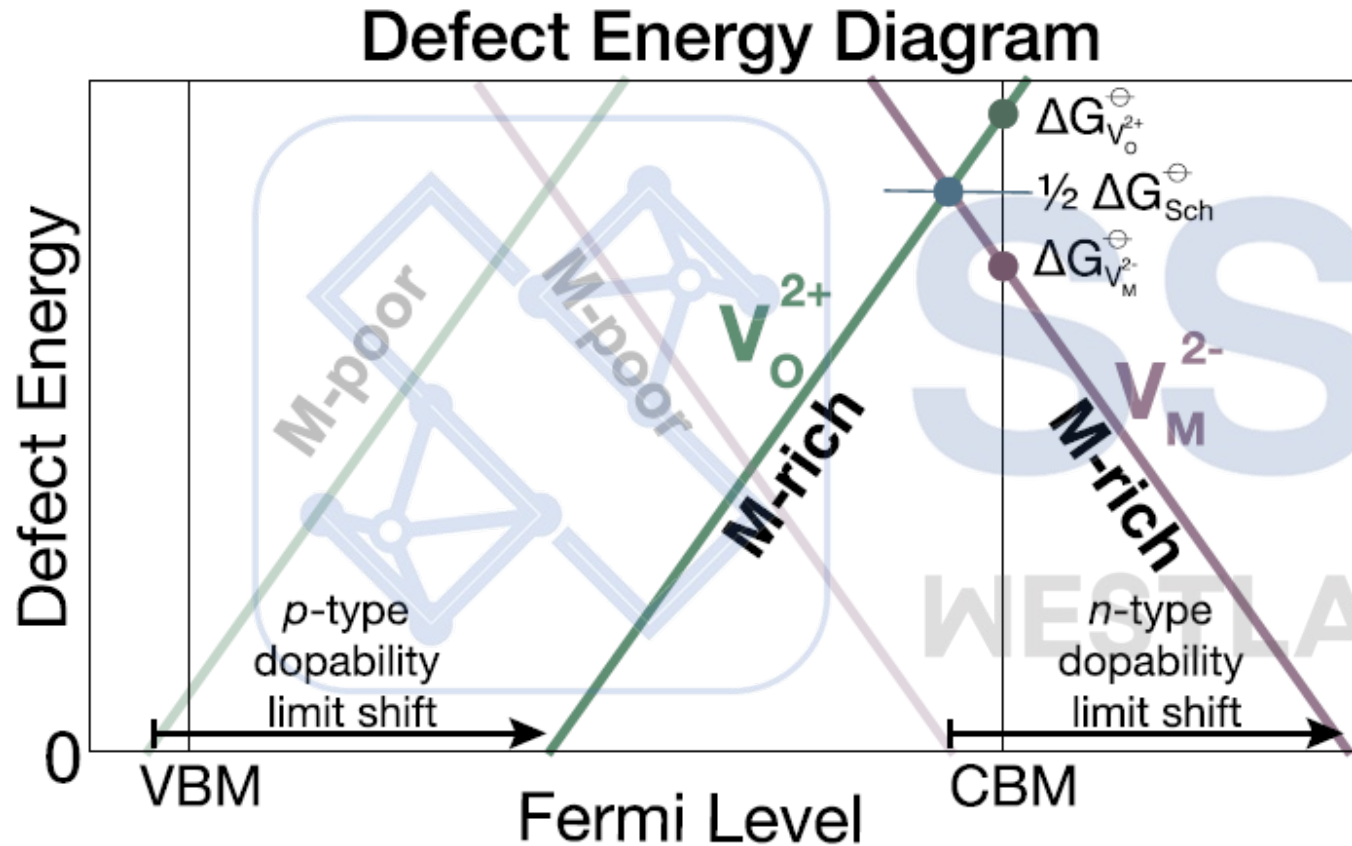
Small Band-gap Semiconductor



$$\mu_O = 1/2 \mu_{O_2}$$

$$\mu_{O_2} = \mu_{O_2}^0 + RT \ln(pO_2/pO_2^0)$$

Another way of expressing formation of defects



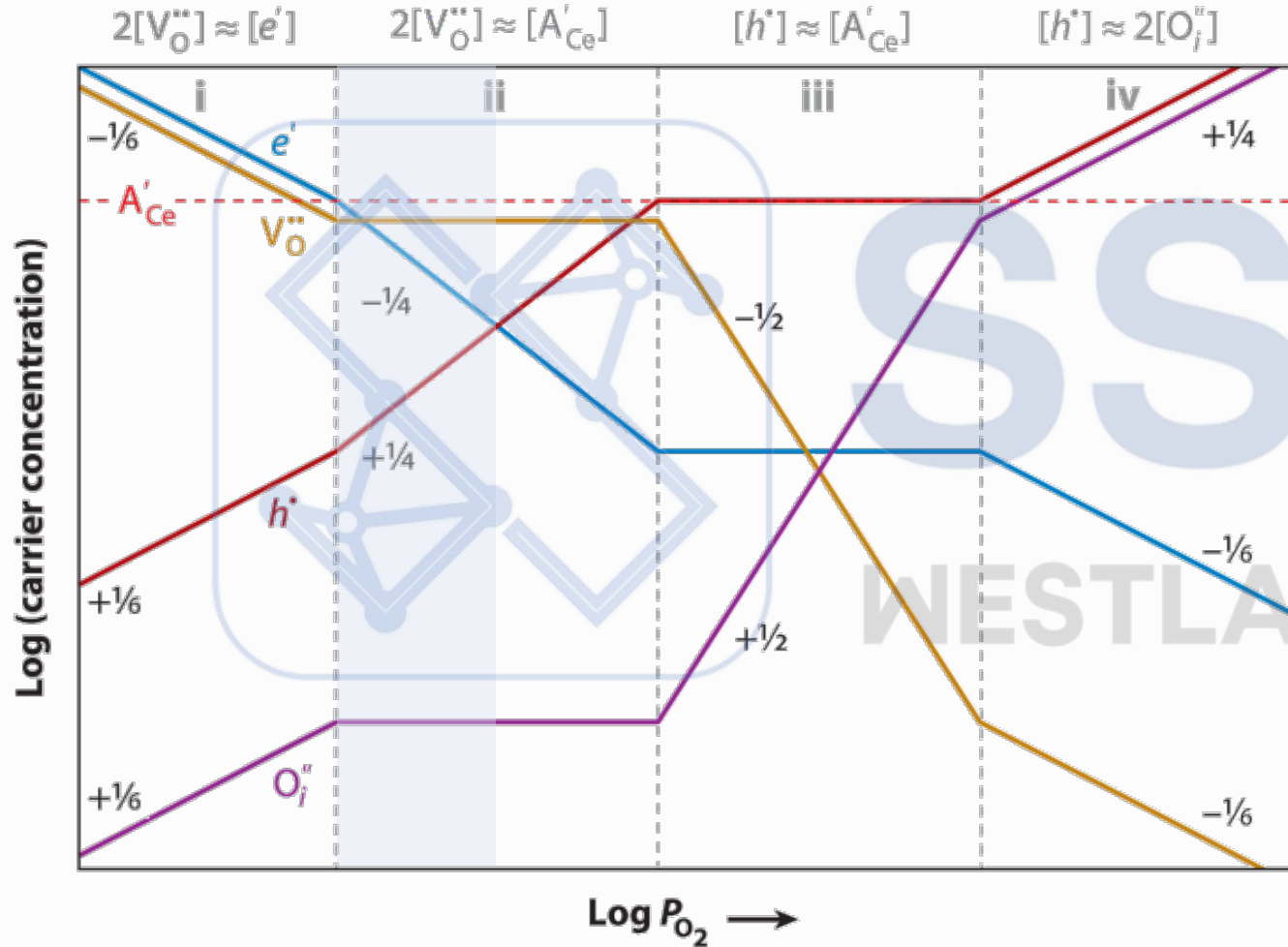
Anand, Haile, Snyder *et al.*, *Acc. Mater. Res.*, 2022

$$\Delta E_d = E_{def} - E_{perfect} + qE_F - \sum_i \Delta N_i \mu_i$$

Fermi level

- Very commonly used by semiconductor physicists, especially those who do DFT calculations, since E_F can be used as a tuning parameter;
- Can be used to **construct/convert to Brouwer diagrams**.

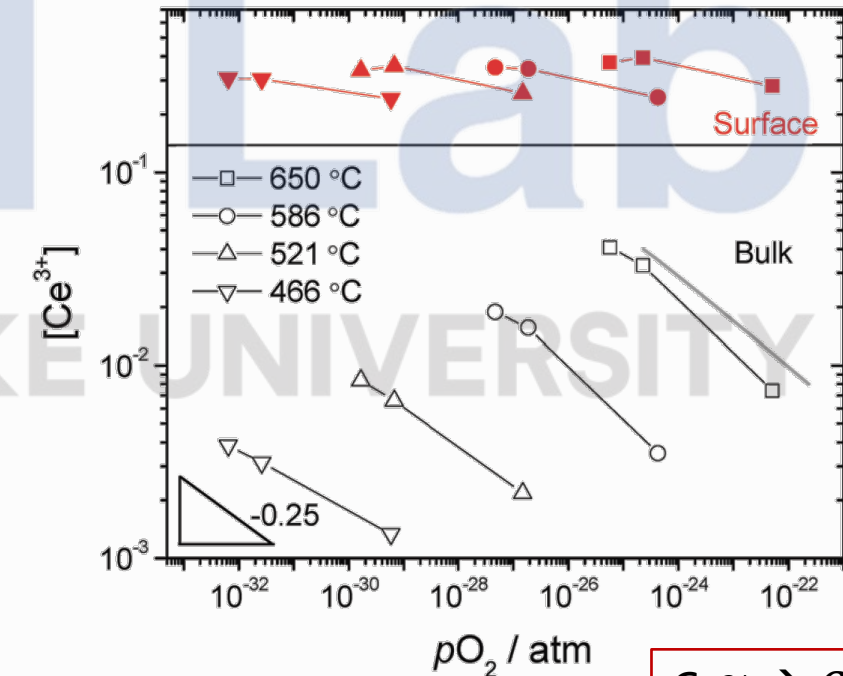
More “realistic” Brouwer diagram w/ Schottky pairs or extrinsic ionic defects



Acceptor-doped $CeO_{2-x-\delta}$

e.g., $Sm_{0.2}Ce_{0.8}O_{1.9-\delta}$

Sm^{3+} replacing $Ce^{4+} \rightarrow Sm'_{Ce}$



Chueh et al., *Chem. Mater.*, 2012

$Ce^{3+} \rightarrow Ce'_{Ce} \rightarrow e'$
“small polaron”

- Direct measurement of defect concentration can be rather difficult;
- The most common practice is to measure the **conductivity** of materials.

Expression of **conductivity**:

$$\sigma = n \cdot ze \cdot M = cN_A \cdot ze \cdot M = czFM$$

σ : Conductivity

c : Charge carrier concentration; N_A : Avogadro constant; F : Faraday constant

ze : Electric charge, for Li^+ , $z = 1$

M : Mobility (usually denoted as μ , but not to be confused with chem. potential)

If we assume that the mobility stays constant within a range of chemical potential, then:

$$\sigma \propto c_{def}$$

Usually, what we measure is the **total** conductivity σ_{tot} :

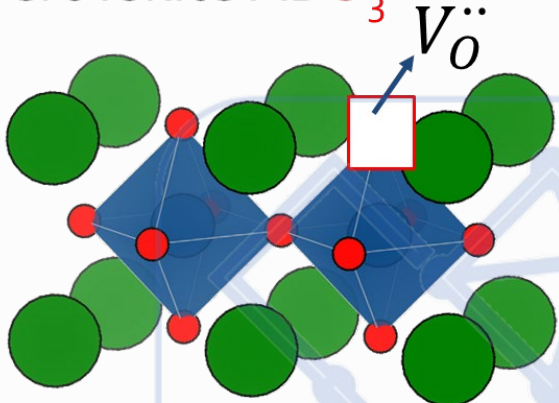
$$\sigma_{tot} = \sigma_{el} + \sigma_{ion}$$

$$\sigma_{el} = n_e e M_e + n_p e M_h$$

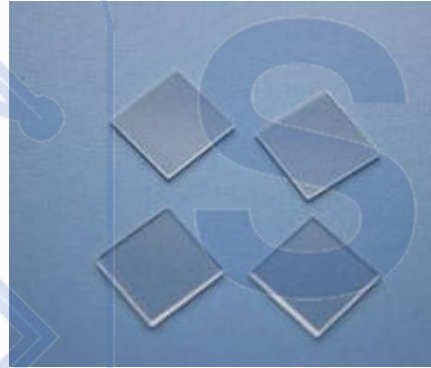
$$\sigma_{ion} = n_{ion} z_{ion} e M_{ion}$$

SrTiO₃ serves as a perfect example to show the $\log \sigma \sim \log p\text{O}_2$ plot

Perovskite ABO_3

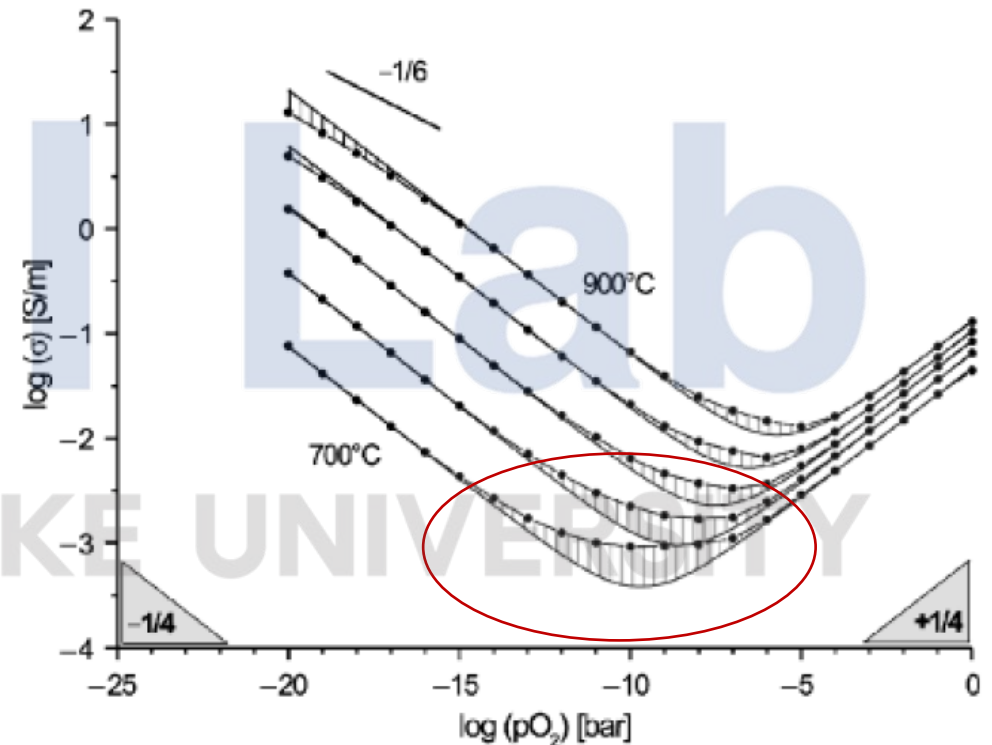


SrTiO_{3-δ} (STO)



Perovskite ABO_3 structure; Cubic (ideal tolerance factor);
("Si for perovskite oxides")

$\log \sigma_{\text{tot}} \sim \log p\text{O}_2$ plot

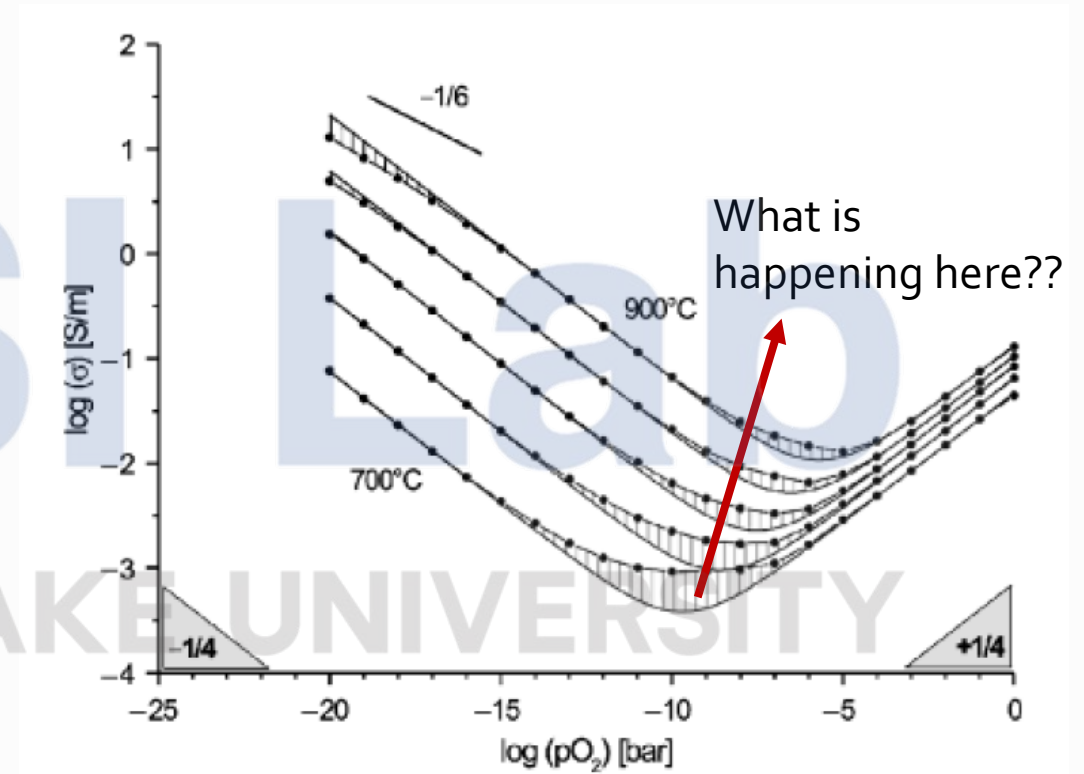
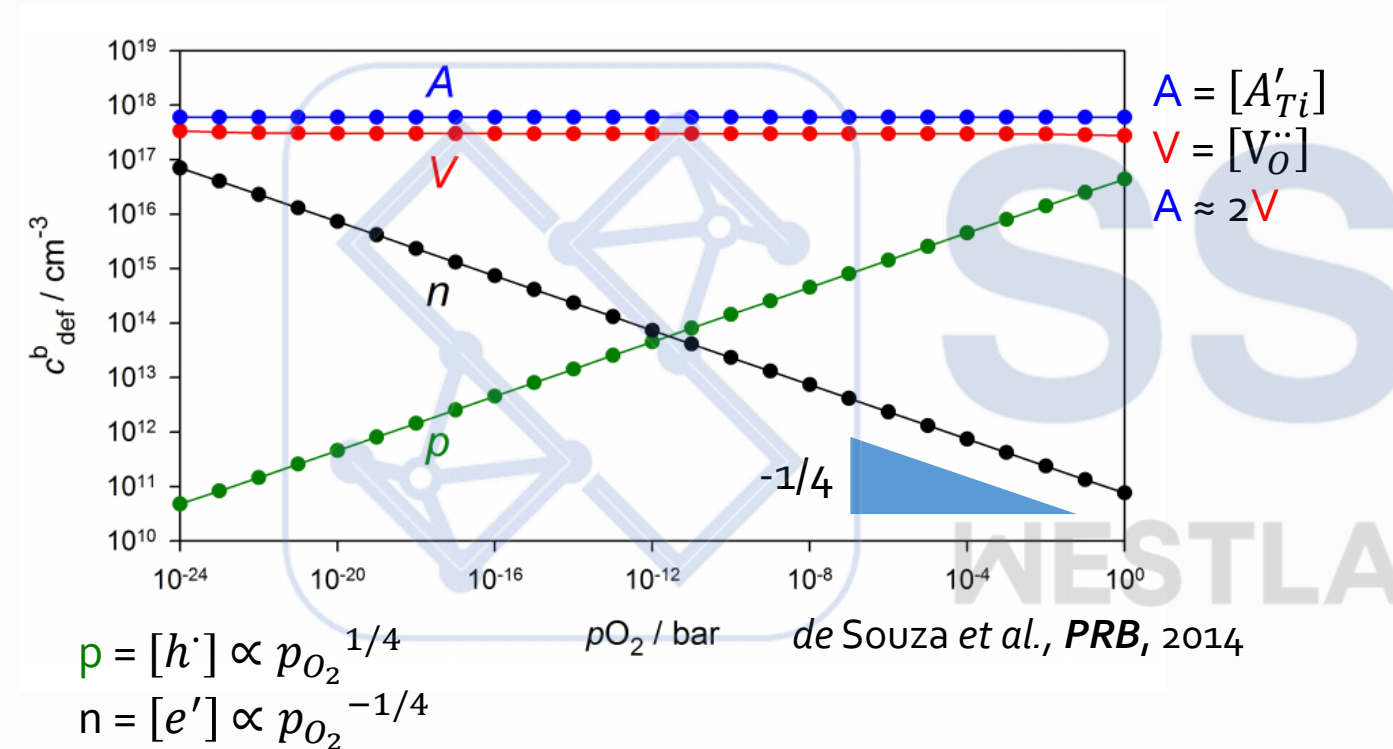


Ohly et al., *J. Am. Ceram. Soc.*, 2006

We want to understand:

- What do the different slopes tell us about ionic and electronic defect equilibrium?
- What does the shaded area mean?

Ionic and electronic conductivity of SrTiO₃



Ohly et al., *J. Am. Ceram. Soc.*, 2006

$$\sigma_{\text{tot}} = ne\mu_e + pe\mu_h + V(Z_V e)\mu_V$$

At ~973 K for SrTiO₃:

$\mu_e, \mu_h \sim 0.1 \text{ cm}^2/(\text{V}\cdot\text{s})$ vs. $\mu_V \sim 4 \times 10^{-4} \text{ cm}^2/(\text{V}\cdot\text{s})$

Brouwer diagram for lithium storage materials

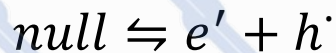
For a lithium-storage material **LiX** that can tolerate both **Li-excess** and **Li-deficiency**, we consider four point defects: Li'_i , V_{Li} , e' , $h\cdot$

Frenkel pair



$$K_F = [Li'_i][V_{Li}]$$

“Band-to-band”



$$K_{el} = [e'][h\cdot]$$

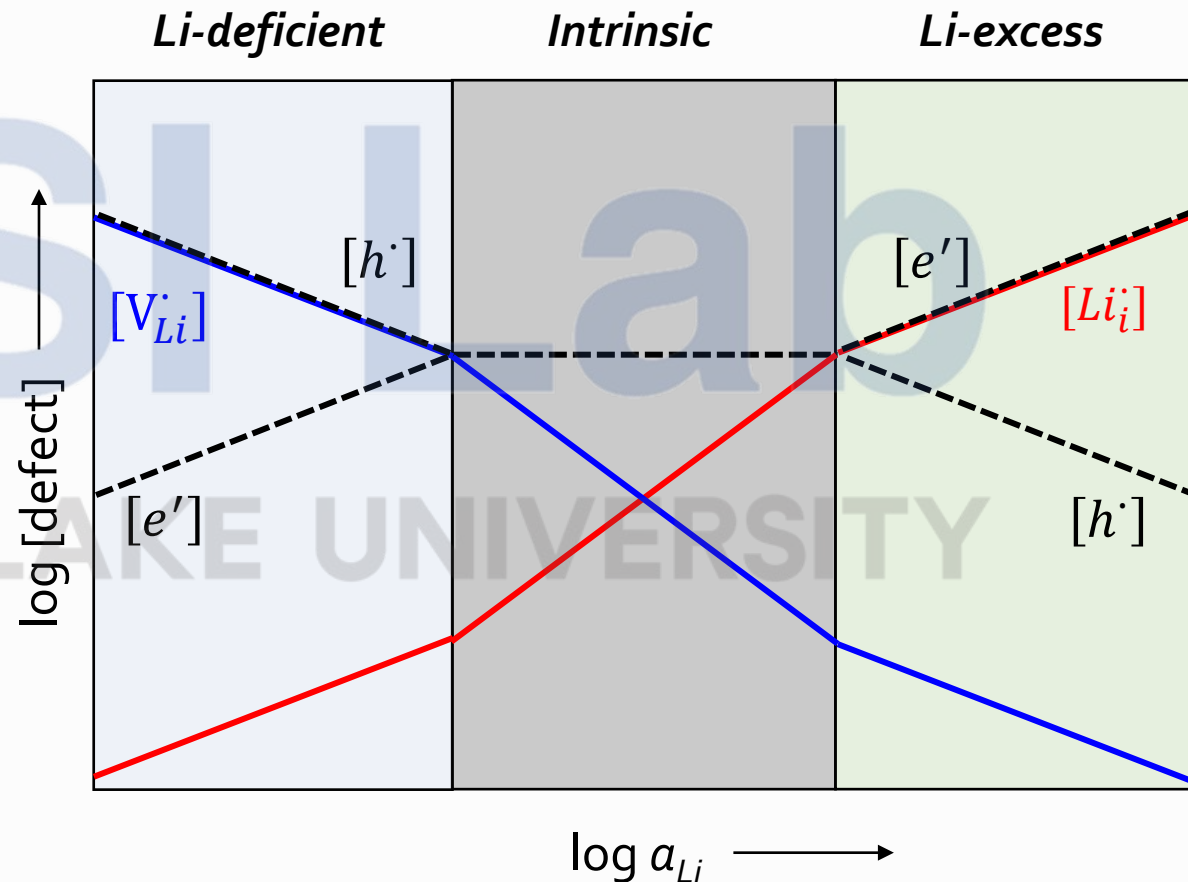
Li intercalation



$$K_{Li} = \frac{[Li'_i][e']}{a_{Li}}$$

$$\mu_{Li} = \mu_{Li}^0 + RT \ln a_{Li}$$

We assume $K_{el} \gg K_F$ (small bandgap)

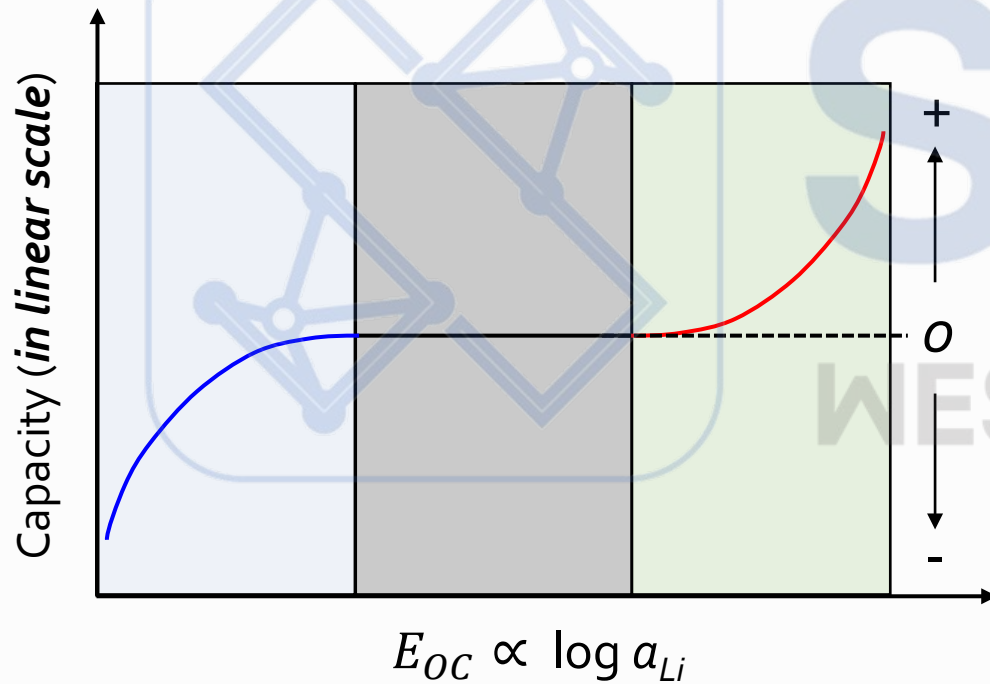


What can we get from such a Brouwer diagram?

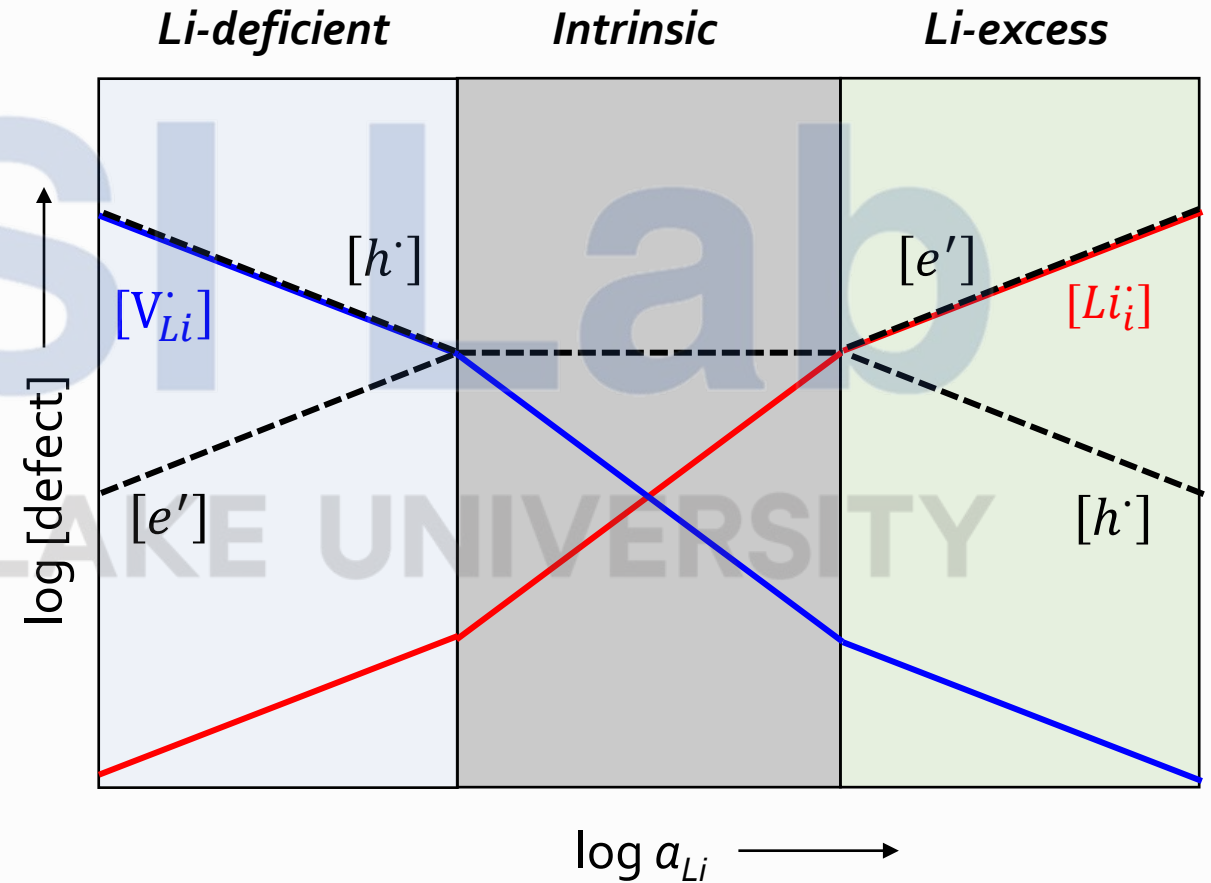
For Li-ion battery materials, we have:

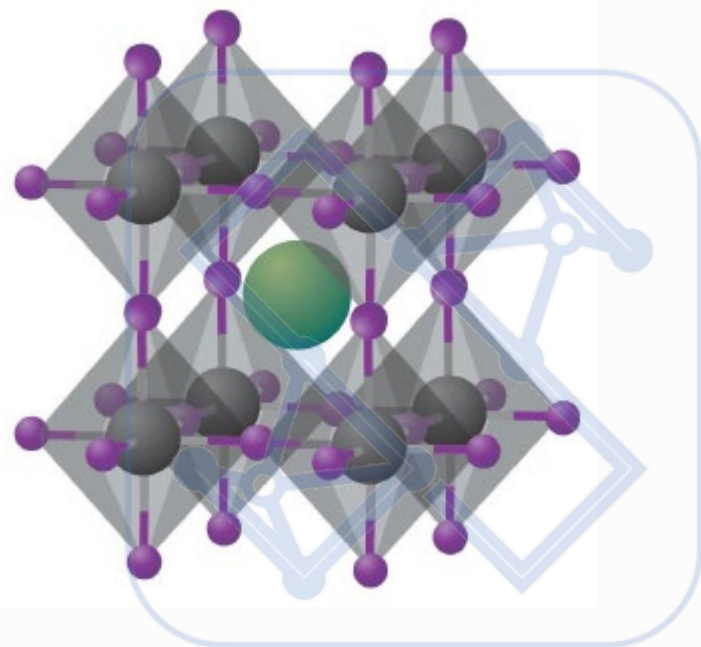
Charge stored: $Q \propto |[Li_i] - [V_{Li}]|$

Open-circuit potential: $E_{OC} \propto \mu_{Li} \propto \ln a_{Li}$



Simulated battery charge/discharge curves (!)





e.g. Methylammonium lead iodide
 $\text{CH}_3\text{NH}_3\text{PbI}_3$ (MAPbI_3)

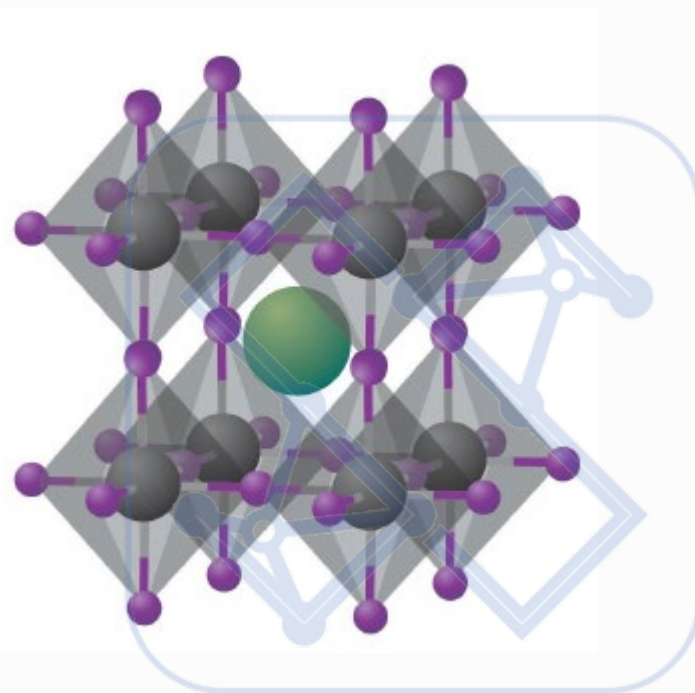
Why do halide perovskites attract so much attention?

- Wide range in composition design: from inorganic compound (*e.g.* CsPbI_3) to organo-metallic compound (*e.g.* MAPbI_3);
- High light absorption coefficient + very long diffusion length of electrons and holes (*i.e.*, very low charge recombination rate)

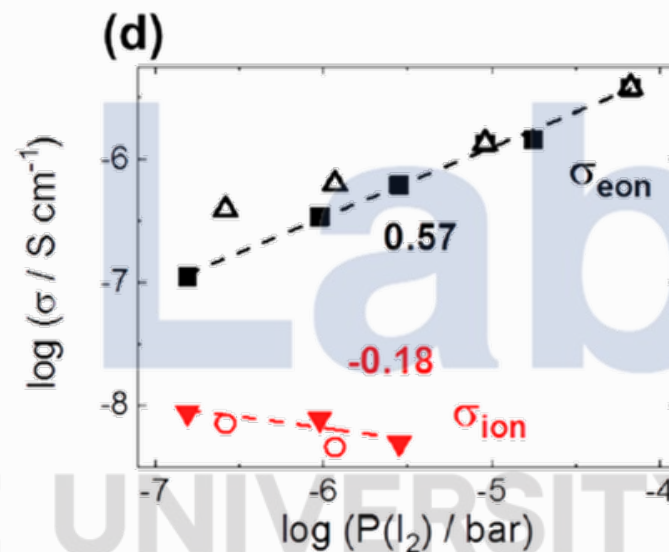
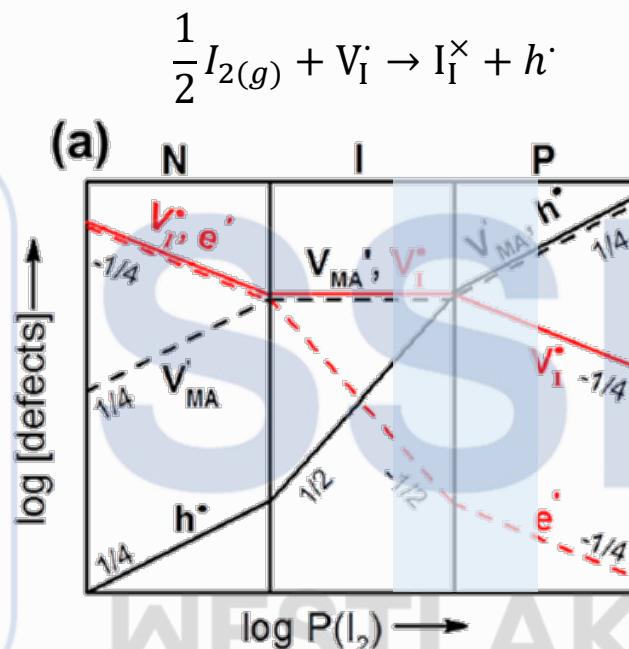
Since halide perovskites are called “*ionic semiconductors*”, we should be able to understand from the perspective of defect chemistry:

- Halide perovskites are ***mixed ionic-electronic conductors***. Therefore, it is important to differentiate ionic and electronic conductivities;
- Peculiar ion transport behavior under illumination. Ionic conductivity is shown higher under light compared with dark condition.

Brouwer diagrams for halide perovskites: *Intrinsic*



Brouwer diagram of MAPbI_3
Measure **ionic** (σ_{ion}) and electronic (σ_{eon}) conductivity as a function of pI_2

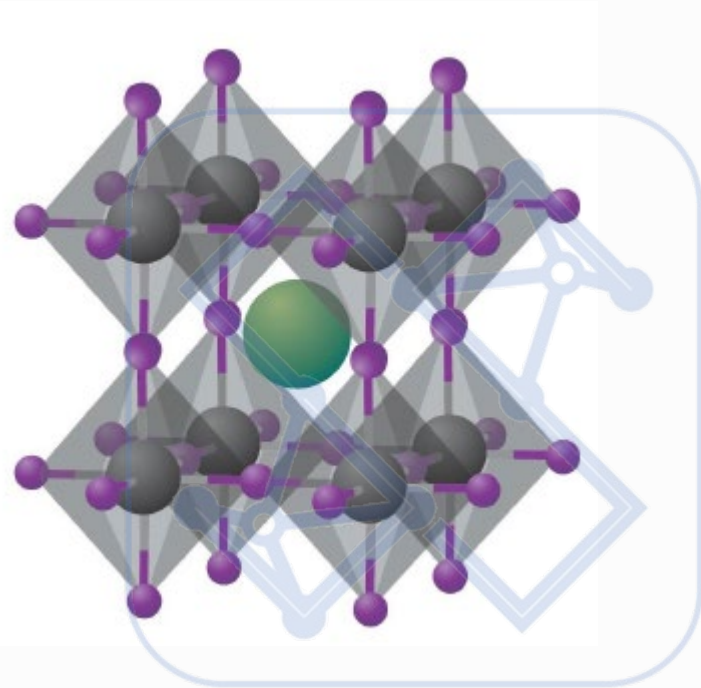


Senocrate and Maier, *J. Am. Chem. Soc.*, 2019

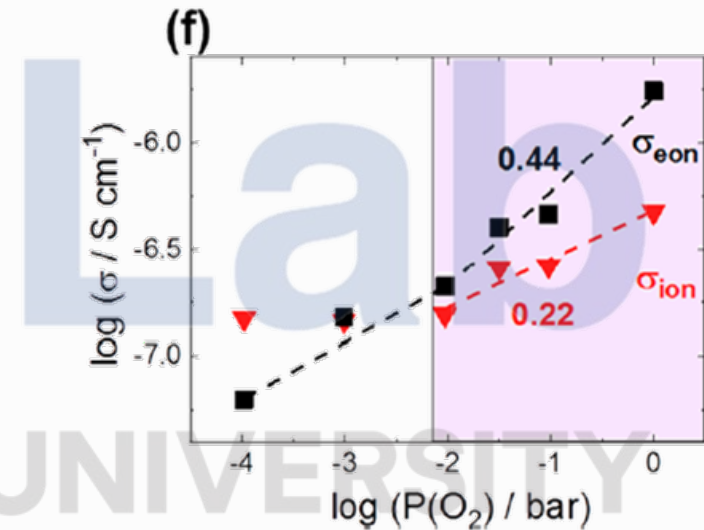
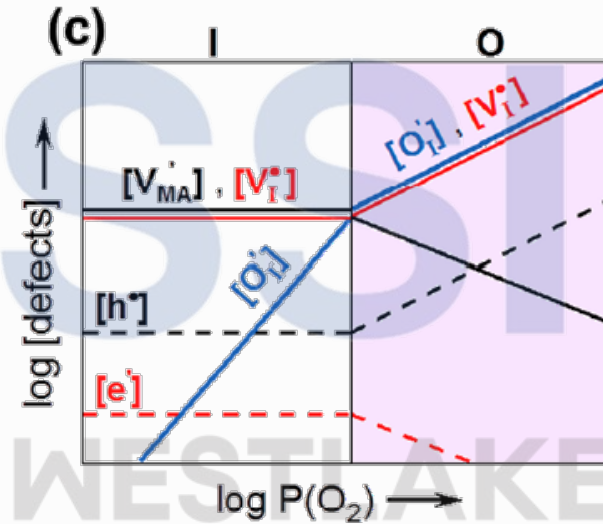
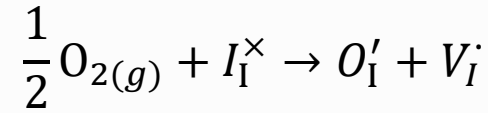
Conclusions:

1. The tested pI_2 range is within the **I-P** transition region in the Brouwer diagram;
(The measured slope has some uncertainties)
2. The dominate ionic mobile defects are the **iodine vacancies**

Brouwer diagrams for halide perovskites: *Intrinsic*



Brouwer diagram of MAPbI_3
 Measure **ionic** (σ_{ion}) and electronic (σ_{eon}) conductivity as a function of $p\text{O}_2$



Senocrate and Maier, *J. Am. Chem. Soc.*, 2019

Conclusion:

Incorporated O ions act as accept dopants, which increases the electronic conductivity.

Electronic defects:

- What is the difference between electronic and ionic defects?
- A brief review on basic semiconductor physics: how to write the charge neutrality equation by using Kröger-Vink notations?

Brouwer diagrams:

- What question are we trying to solve by using the Brouwer diagram?
- What is the key assumption of Brouwer diagram (so-called Brouwer condition)?
- How does a typical Brouwer diagram for metal oxides look like? How can it be used to predict/understand the conductivity of materials?

Goal of this lecture: you should be able to answer the questions above now (hopefully) :)

End of Lecture 2

Solid State Ionics Fall 2022

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